## Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/573,731	Reexamination DOTTLING ET AI	-
Examiner	Art Unit	
Meless N. Zewdu	2617	Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0088643 A1	05-2004	Kobayashi, Yoshikazu	714/776
*	В	US-2003/0165161 A1	09-2003	Kalliokulju et al.	370/466
*	С	US-6,731,618 B1	05-2004	Chung et al.	370/328
*	D	US-7,269,527 B2	09-2007	Frank, David L.	702/108
*	Е	US-7,366,119 B2	04-2008	Ahn, Hee Jun	370/310
*	F	US-6,519,731 B1	02-2003	Huang et al.	714/751
	G	US-		-	
	Н	US-			
		US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

	TOTAL OF THE STATE					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 2 350 984 A	12-2000	GB	Winga HO	H04L 1/00
	0	EP 1 328 096 A2	07-2003	EP	Park et al.	H04L 12/56
	Œ.					
	ø					
	R					
	Ø					
	Т					

## NON DATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
Ī	U	model de approduct. Factor, Tab Sale, Factoria, Edward France, Followin Fagury		
	v			
	w			
	x			

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.